

### FEATURES

- Cu Base with Enhanced Al<sub>2</sub>O<sub>3</sub> Substrates
- 10μs Short Circuit Withstand

### APPLICATIONS

- Motor Drives
- Power Charging Equipment
- Solar Power
- High Reliability Inverters

The Powerline range of high power modules includes half bridge, chopper, dual, single and bi-directional switch configurations covering voltages from 1200V to 6500V and currents up to 2400A.

The TG600HF12M1-S3A00 is a half bridge 1200V, n-channel enhancement mode, insulated gate bipolar transistor (IGBT) module. The IGBT has a wide reverse bias safe operating area (RBSOA) plus 10μs short circuit withstand. This device is optimised for traction drives and other applications requiring high thermal cycling capability.

The module incorporates an electrically isolated base plate and low inductance construction enabling circuit designers to optimise circuit layouts and utilise grounded heat sinks for safety.

### ORDERING INFORMATION

Order As:

#### TG600HF12M1-S3A00

Note: When ordering, please use the complete part number

### KEY PARAMETERS

$V_{CES}$	<b>1200V</b>
$V_{CE(sat)}$ * (typ)	<b>1.70V</b>
$I_C$ (max)	<b>600A</b>
$I_{C(PK)}$ (max)	<b>1200A</b>

\* Measured at the auxiliary terminals

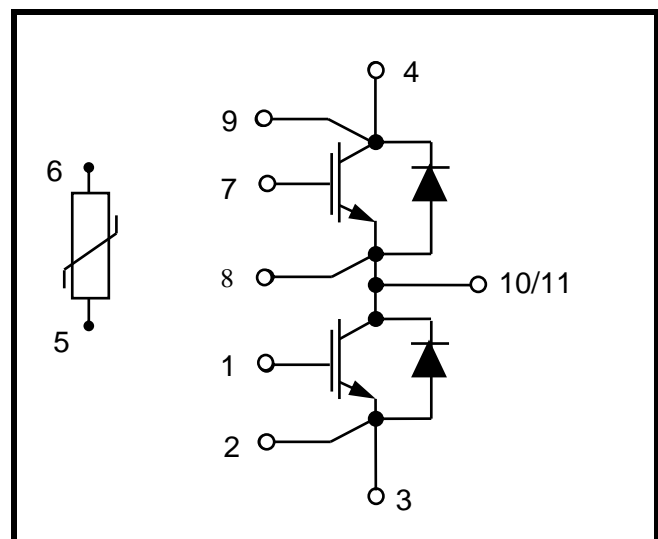


Fig. 1 Circuit configuration



Fig. 2 Package

### ABSOLUTE MAXIMUM RATINGS

Stresses above those listed under ‘Absolute Maximum Ratings’ may cause permanent damage to the device. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture of the package. Appropriate safety precautions should always be followed. Exposure to Absolute Maximum Ratings may affect device reliability.

$T_{case} = 25^{\circ}\text{C}$  unless stated otherwise

Symbol	Parameter	Test Conditions	Max.	Units
$V_{CES}$	Collector-emitter voltage	$V_{GE} = 0\text{V}, T_C = 25^{\circ}\text{C}$	1200	V
$V_{GES}$	Gate-emitter voltage	$T_C = 25^{\circ}\text{C}$	$\pm 20$	V
$I_C$	Continuous collector current	$T_C = 88^{\circ}\text{C}$	600	A
$I_{C(PK)}$	Peak collector current	$t_p = 1\text{ms}, T_C = 133^{\circ}\text{C}$	1200	A
$P_{max}$	Max. transistor power dissipation	$T_C = 25^{\circ}\text{C}, T_{vj} = 175^{\circ}\text{C}$	3.0	kW
$I^2t$	Diode $I^2t$ value	$V_R = 0, t_p = 10\text{ms}, T_{vj} = 150^{\circ}\text{C}$	28.8	$\text{kA}^2\text{s}$
$V_{isol}$	Isolation voltage – per module	Commoned terminals to base plate. AC RMS, 1 min, 50Hz	2500	V

### THERMAL AND MECHANICAL RATINGS

Internal insulation material:	$\text{Al}_2\text{O}_3$
Baseplate material:	Cu
Creepage distance – Terminal to heatsink:	14.5mm
Creepage distance – Terminal to terminal:	13.0mm
Clearance – Terminal to heatsink:	12.5mm
Clearance – Terminal to terminal:	10mm
CTI (Comparative Tracking Index):	>200

Symbol	Parameter	Test Conditions	Min	Typ.	Max	Units
$R_{th(j-c)}$	Thermal resistance – IGBT	Continuous dissipation - junction to case	-	-	49	$^{\circ}\text{C}/\text{kW}$
$R_{th(j-c)}$	Thermal resistance – diode		-	-	77	$^{\circ}\text{C}/\text{kW}$
$R_{th(c-h)}$	Thermal resistance – case to heatsink (IGBT)	Mounting torque 5Nm (with mounting grease $1\text{W}/\text{m}^{\circ}\text{C}$ )	-	-	34	$^{\circ}\text{C}/\text{kW}$
$R_{th(c-h)}$	Thermal resistance – case to heatsink (Diode)		-	-	40	$^{\circ}\text{C}/\text{kW}$
$T_j$	Junction temperature	IGBT	-40	-	150	$^{\circ}\text{C}$
		Diode	-40	-	150	$^{\circ}\text{C}$
$T_{stg}$	Storage temperature range	-	-40	-	150	$^{\circ}\text{C}$
	Screw torque	Mounting – M5	3	-	6	Nm
		Electrical connections – M6	3	-	6	Nm

**ELECTRICAL CHARACTERISTICS**
**T<sub>case</sub> = 25°C unless stated otherwise.**

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
I <sub>CES</sub>	Collector cut-off current	V <sub>GE</sub> = 0V, V <sub>CE</sub> = V <sub>CES</sub>			1	mA
		V <sub>GE</sub> = 0V, V <sub>CE</sub> = V <sub>CES</sub> , T <sub>C</sub> = 125°C			10	mA
		V <sub>GE</sub> = 0V, V <sub>CE</sub> = V <sub>CES</sub> , T <sub>C</sub> = 150°C			20	mA
I <sub>GES</sub>	Gate leakage current	V <sub>GE</sub> = ± 20V, V <sub>CE</sub> = 0V			0.5	μA
V <sub>GE(TH)</sub>	Gate threshold voltage	I <sub>C</sub> = 15mA, V <sub>GE</sub> = V <sub>CE</sub>	5.0	6.0	7.0	V
V <sub>CE(sat)</sub>	Collector-emitter saturation voltage	V <sub>GE</sub> = 15V, I <sub>C</sub> = 600A		1.7		V
		V <sub>GE</sub> = 15V, I <sub>C</sub> = 600A, T <sub>j</sub> = 125°C		2.0		V
		V <sub>GE</sub> = 15V, I <sub>C</sub> = 600A, T <sub>j</sub> = 150°C		2.1		V
I <sub>F</sub>	Diode forward current	DC		600		A
I <sub>FM</sub>	Diode maximum forward current	t <sub>p</sub> = 1ms		1200		A
V <sub>F</sub>	Diode forward voltage	I <sub>F</sub> = 600A		1.9		V
		I <sub>F</sub> = 600A, T <sub>j</sub> = 125°C		2.1		V
		I <sub>F</sub> = 600A, T <sub>j</sub> = 150°C		2.1		V
C <sub>ies</sub>	Input capacitance	V <sub>CE</sub> = 25V, V <sub>GE</sub> = 0V, f = 100kHz		57		nF
Q <sub>g</sub>	Gate charge	±15V		6.1		μC
C <sub>res</sub>	Reverse transfer capacitance	V <sub>CE</sub> = 25V, V <sub>GE</sub> = 0V, f = 1MHz		1.8		nF
L <sub>M</sub>	Module inductance			22		nH
R <sub>INT</sub>	Internal transistor resistance			1		mΩ
SC <sub>Data</sub>	Short circuit current, I <sub>SC</sub>	T <sub>j</sub> = 150°C, V <sub>CC</sub> = 800V t <sub>p</sub> ≤ 10μs, V <sub>GE</sub> ≤ 15V V <sub>CE(max)</sub> = V <sub>CES</sub> - L* x di/dt IEC 60747-9		2800		A

**Note:**

 \* L is the circuit inductance + L<sub>M</sub>
**NTC-Thermistor Data**

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
R <sub>25</sub>	Rated resistance	T <sub>C</sub> = 25°C		5		kΩ
ΔR/R	Deviation of R <sub>100</sub>	T <sub>C</sub> = 100°C, R <sub>100</sub> = 493Ω	-5		5	%
P <sub>25</sub>	Power dissipation	T <sub>C</sub> = 25°C			20	mW
B <sub>25/50</sub>	B-value	R <sub>2</sub> = R <sub>25</sub> exp [B <sub>25/50</sub> (1/T <sub>2</sub> - 1/(298.15K))]		3375		K
B <sub>25/80</sub>		R <sub>2</sub> = R <sub>25</sub> exp [B <sub>25/80</sub> (1/T <sub>2</sub> - 1/(298.15K))]		3411		K
B <sub>25/100</sub>		R <sub>2</sub> = R <sub>25</sub> exp [B <sub>25/100</sub> (1/T <sub>2</sub> - 1/(298.15K))]		3433		K

**ELECTRICAL CHARACTERISTICS**

**T<sub>case</sub> = 25°C unless stated otherwise**

Symbol	Parameter	Test Conditions		Min	Typ.	Max	Units
t <sub>d(off)</sub>	Turn-off delay time	I <sub>C</sub> = 600A V <sub>CE</sub> = 600V V <sub>GE</sub> = ±15V R <sub>G(OFF)</sub> = 0.5Ω R <sub>G(ON)</sub> = 0.5Ω L <sub>S</sub> ~ 40nH	dv/dt = 3500V/μs		710		ns
t <sub>f</sub>	Fall time				280		ns
E <sub>OFF</sub>	Turn-off energy loss				90		mJ
t <sub>d(on)</sub>	Turn-on delay time		di/dt = 6000A/μs		185		ns
t <sub>r</sub>	Rise time				92		ns
E <sub>ON</sub>	Turn-on energy loss				22		mJ
Q <sub>rr</sub>	Diode reverse recovery charge	I <sub>F</sub> = 600A V <sub>CE</sub> = 600V di/dt = 6000A/μs			52		μC
I <sub>rr</sub>	Diode reverse recovery current				365		A
E <sub>rec</sub>	Diode reverse recovery energy				29		mJ

**T<sub>case</sub> = 125°C unless stated otherwise**

Symbol	Parameter	Test Conditions		Min	Typ.	Max	Units
t <sub>d(off)</sub>	Turn-off delay time	I <sub>C</sub> = 600A V <sub>CE</sub> = 600V V <sub>GE</sub> = ±15V R <sub>G(OFF)</sub> = 0.5Ω R <sub>G(ON)</sub> = 0.5Ω L <sub>S</sub> ~ 40nH	dv/dt = 3500V/μs		780		ns
t <sub>f</sub>	Fall time				400		ns
E <sub>OFF</sub>	Turn-off energy loss				102		mJ
t <sub>d(on)</sub>	Turn-on delay time		di/dt = 6000A/μs		180		ns
t <sub>r</sub>	Rise time				98		ns
E <sub>ON</sub>	Turn-on energy loss				32		mJ
Q <sub>rr</sub>	Diode reverse recovery charge	I <sub>F</sub> = 600A V <sub>CE</sub> = 600V di/dt = 6000A/μs			78		μC
I <sub>rr</sub>	Diode reverse recovery current				420		A
E <sub>rec</sub>	Diode reverse recovery energy				43		mJ

**T<sub>case</sub> = 150°C unless stated otherwise**

Symbol	Parameter	Test Conditions		Min	Typ.	Max	Units
t <sub>d(off)</sub>	Turn-off delay time	I <sub>C</sub> = 600A V <sub>CE</sub> = 600V V <sub>GE</sub> = ±15V R <sub>G(OFF)</sub> = 0.5Ω R <sub>G(ON)</sub> = 0.5Ω L <sub>S</sub> ~ 40nH	dv/dt = 3500V/μs		800		ns
t <sub>f</sub>	Fall time				430		ns
E <sub>OFF</sub>	Turn-off energy loss				105		mJ
t <sub>d(on)</sub>	Turn-on delay time		di/dt = 6000A/μs		180		ns
t <sub>r</sub>	Rise time				100		ns
E <sub>ON</sub>	Turn-on energy loss				34		mJ
Q <sub>rr</sub>	Diode reverse recovery charge	I <sub>F</sub> = 600A V <sub>CE</sub> = 600V di/dt = 6000A/μs			100		μC
I <sub>rr</sub>	Diode reverse recovery current				450		A
E <sub>rec</sub>	Diode reverse recovery energy				55		mJ

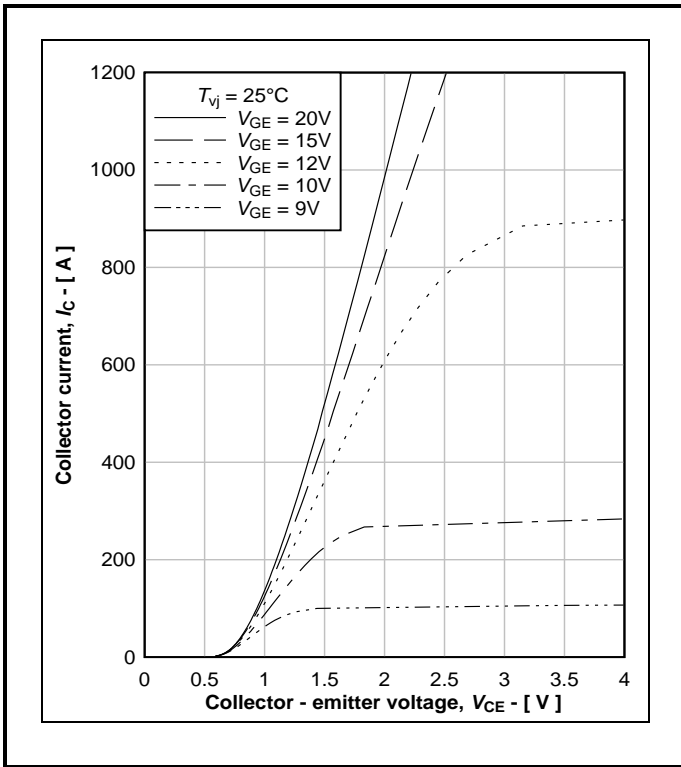


Fig. 3 Typical IGBT output characteristics,  $I_C = f(V_{CE})$

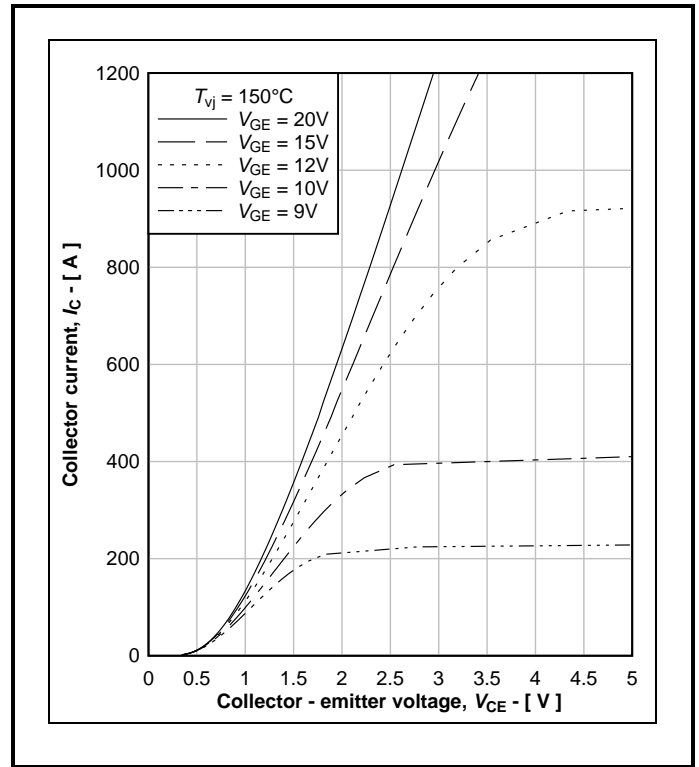


Fig. 4 Typical IGBT output characteristics,  $I_C = f(V_{CE})$

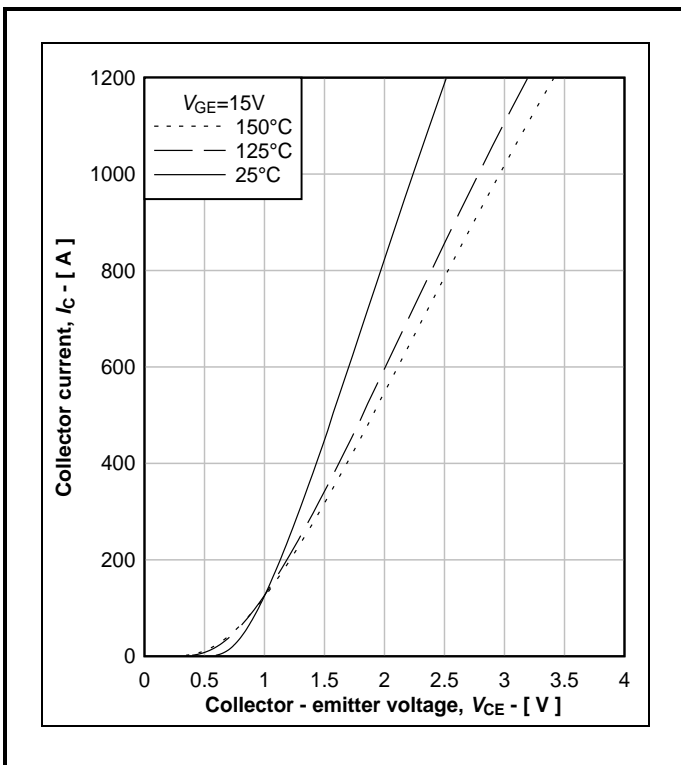


Fig. 5 Typical IGBT output characteristics,  $I_C = f(V_{CE})$

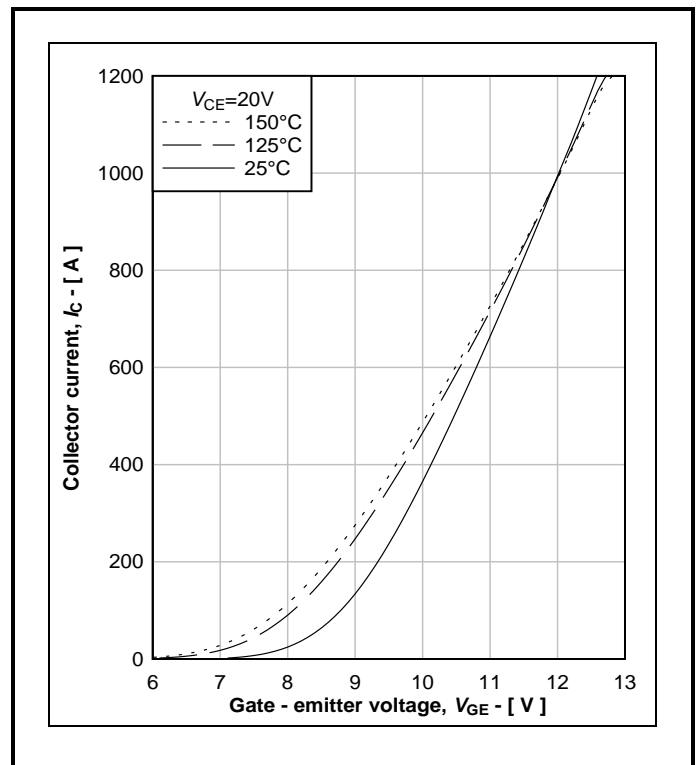


Fig. 6 Typical IGBT transfer characteristics,  $I_C = f(V_{GE})$

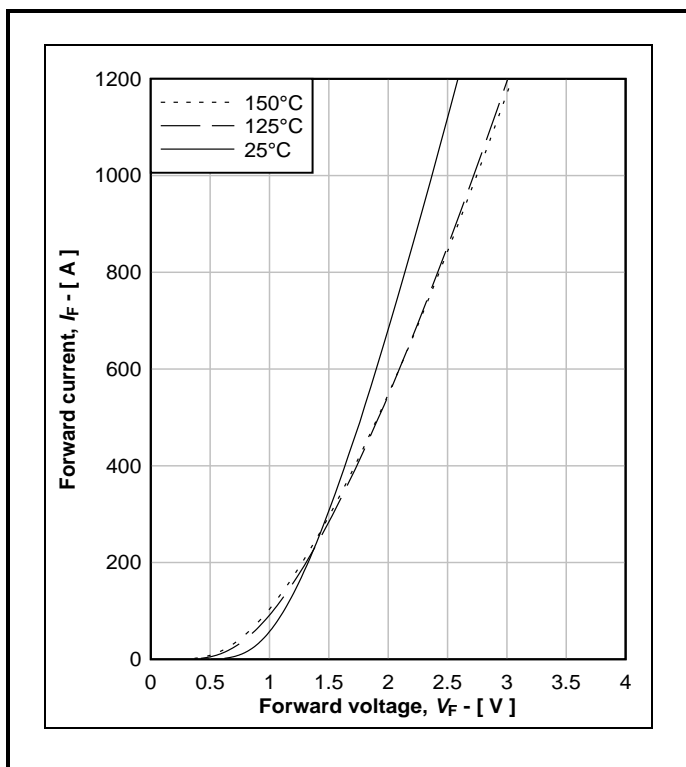


Fig. 7 Diode typical forward characteristics,  $I_F = f(V_F)$

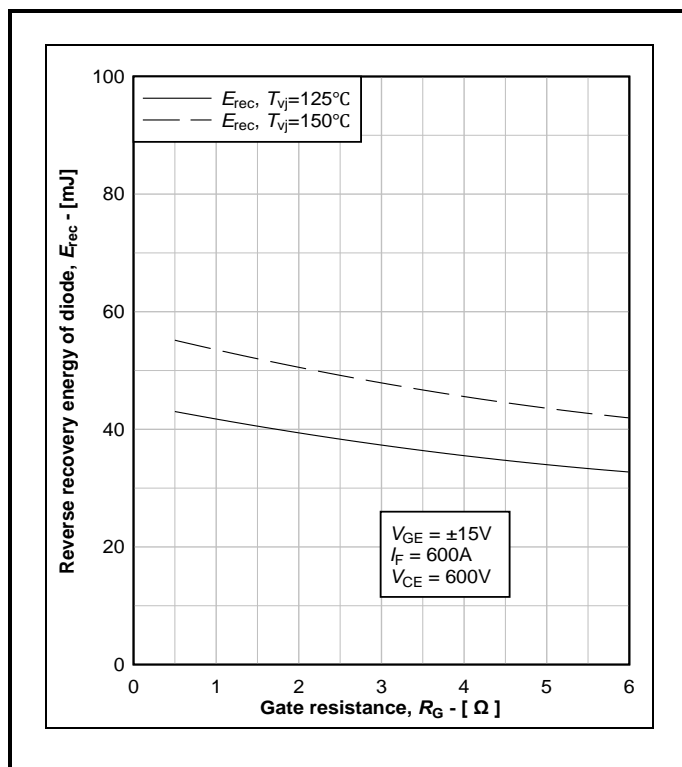


Fig. 8 Typical FRD  $E_{rec}$ ,  $E_{rec} = f(R_G)$

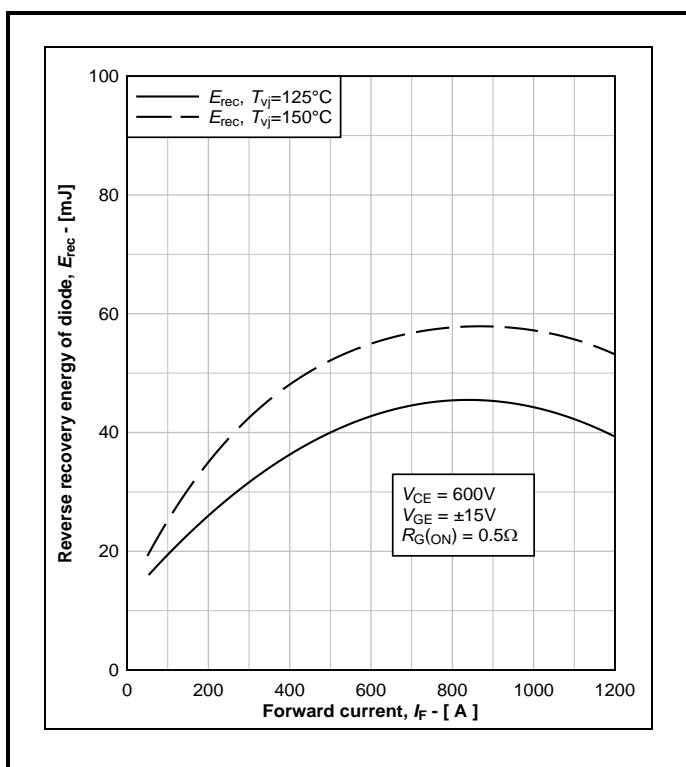


Fig. 9 Typical FRD  $E_{rec}$ ,  $E_{rec} = f(I_F)$

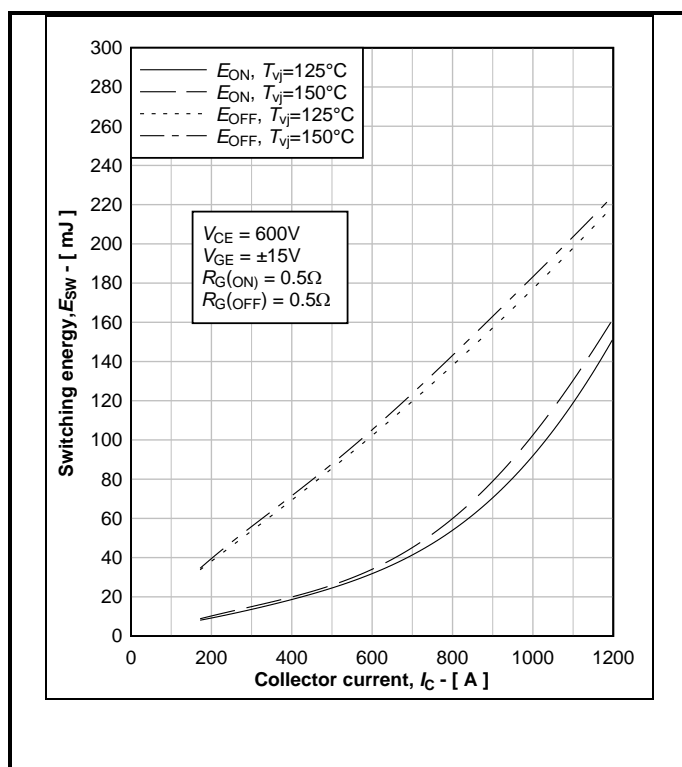
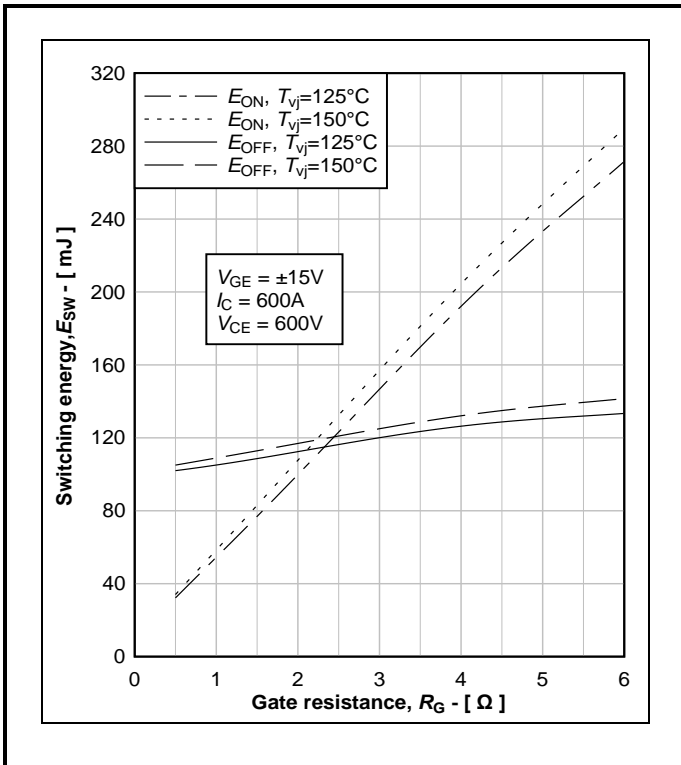
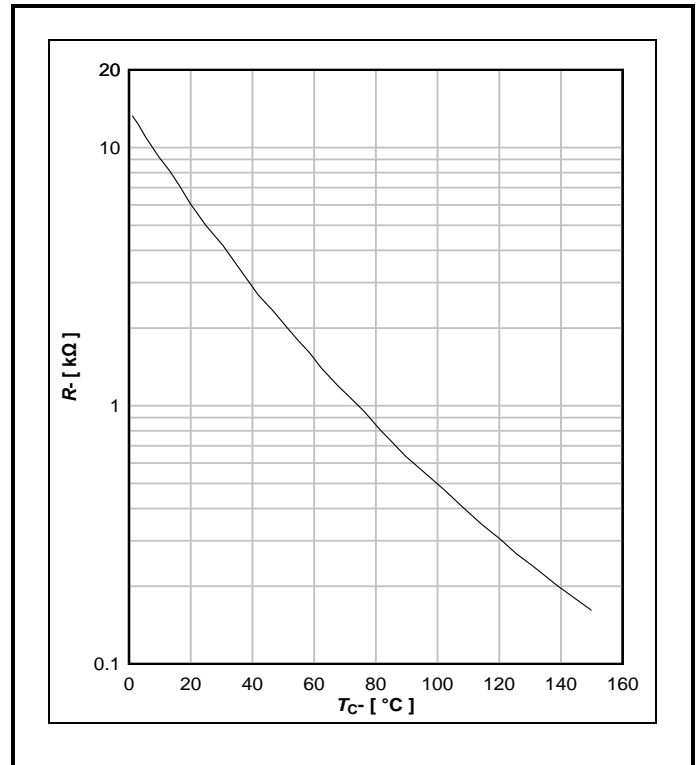


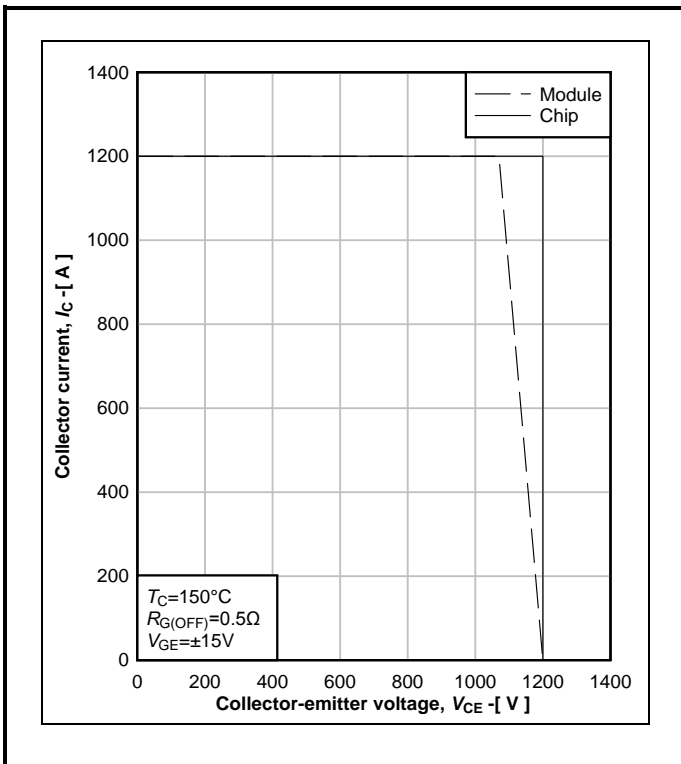
Fig. 10 Typical IGBT switching energy,  $E_{ON} = f(I_C)$ ,  $E_{OFF} = f(I_C)$



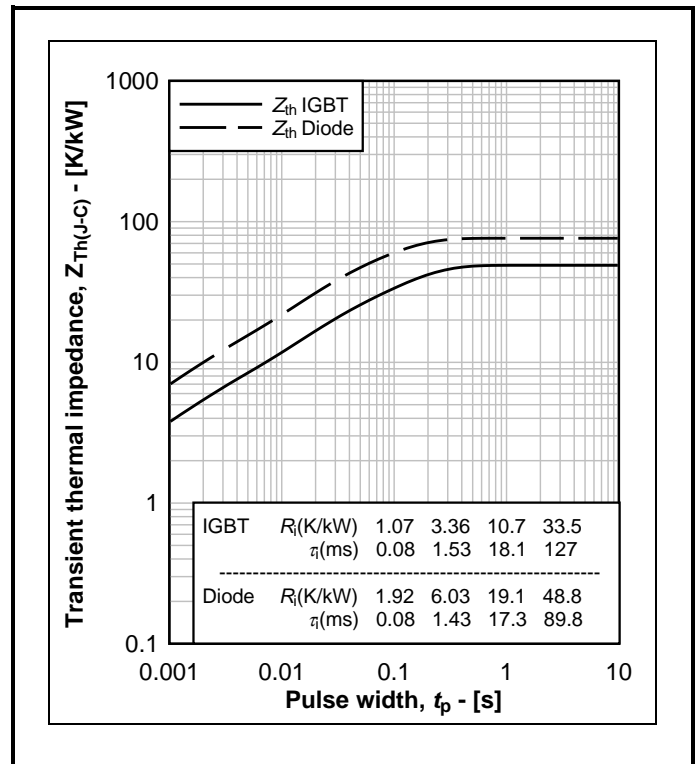
**Fig. 11 Typical IGBT switching energy**  
 $E_{ON} = f(R_G)$ ,  $E_{OFF} = f(R_G)$



**Fig. 12 Typical NTC thermistor characteristic,  $R = f(T_C)$**



**Fig. 13 Reverse bias safe operating area of IGBT,**  
 $I_C = f(V_{CE})$



**Fig. 14 Transient thermal impedance,  $Z_{th(J-C)} = f(t)$**

PACKAGE DETAILS

For further package information, please visit our website or contact Customer Services.  
All dimensions in mm, unless stated otherwise.  
**DO NOT SCALE.**

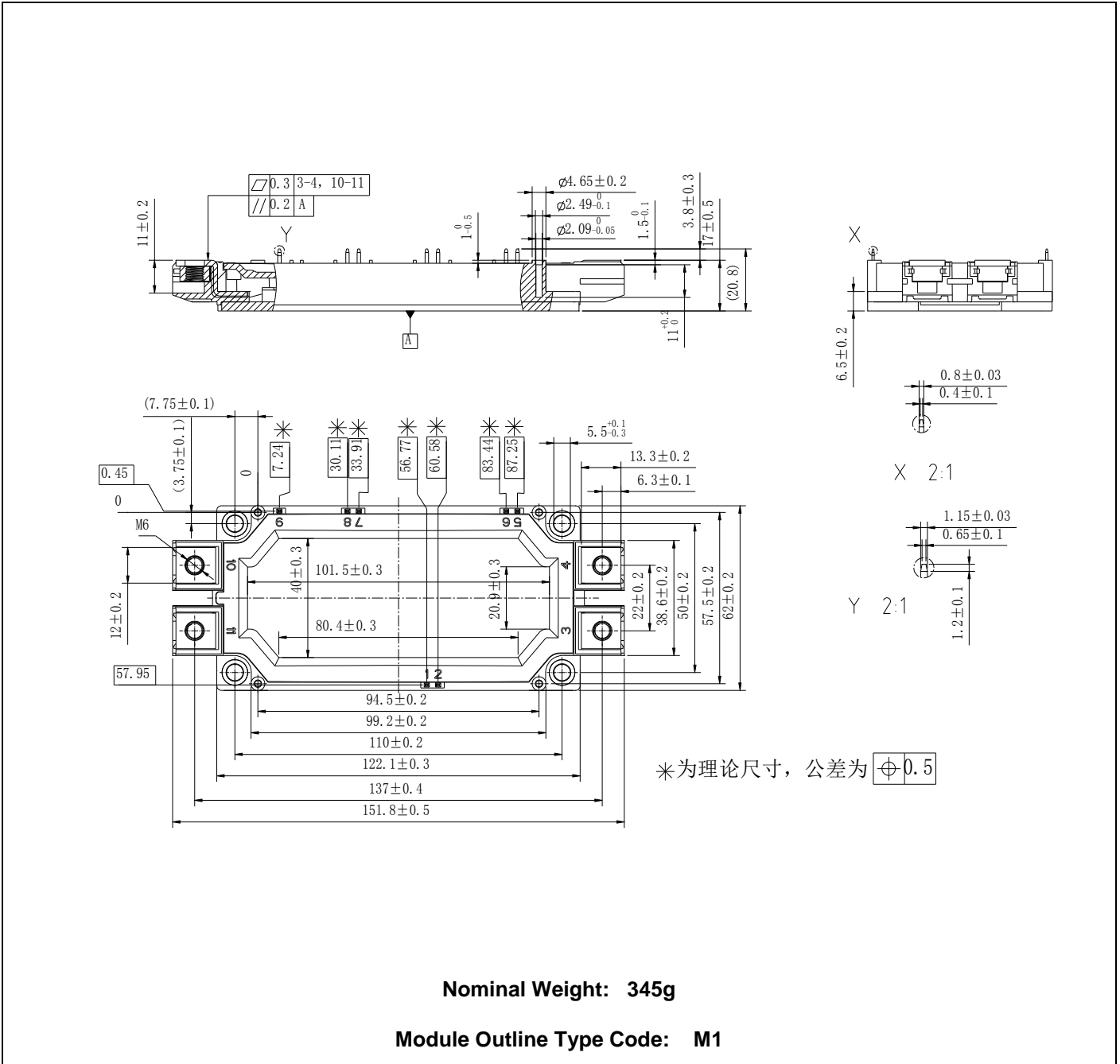


Fig. 15 Module outline drawing



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**HEADQUARTERS OPERATIONS****DYNEX SEMICONDUCTOR LTD**

Doddington Road, Lincoln, Lincolnshire, LN6 3LF,  
United Kingdom

Fax: +44(0)1522 500550

Tel: +44(0)1522 500500

Web: <http://www.dynexsemi.com>

**CUSTOMER SERVICE****DYNEX SEMICONDUCTOR LTD**

Doddington Road, Lincoln, Lincolnshire, LN6 3LF,  
United Kingdom

Fax: +44(0)1522 500020

Tel: +44(0)1522 502753 / 502901

Email: [Power\\_solutions@dynexsemi.com](mailto:Power_solutions@dynexsemi.com)